

Smart high-side NMOS-power switch

ITS4060S-SJ-N



Features

- CMOS compatible input
- Switching all types of resistive, inductive and capacitive loads
- Fast demagnetization of inductive loads
- Very low standby current
- Optimized Electromagnetic Compatibility (EMC)
- Overload protection
- **Current limitation**
- Short circuit protection
- Thermal shutdown with restart
- Overvoltage protection (including load dump)
- Reverse battery protection with external resistor
- Loss of GND and loss of Vbb protection
- **Electrostatic Discharge Protection (ESD)**
- Green Product (RoHS compliant)

Applications

- All types of resistive, inductive and capacitive loads
- Power switch for 12V and 24V DC applications with CMOS compatible control interface
- Driver for electromagnetic relays
- Power management for high-side-switching with low current consumption in OFF-mode

Product validation

Qualified for industrial applications according to the relevant tests of JEDEC.

Description

The ITS4060S-SJ-N is a protected single channel smart high-side NMOS power switch in a PG-DSO-8 package with charge pump and CMOS compatible input. The device is monolithically integrated in Smart technology.

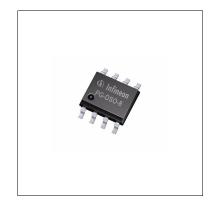




Table 1 **Product summary**

Parameter	Symbol	Values
Overvoltage protection	V_{SAZmin}	41 V
Operating voltage range	V_{S}	5 < V _S < 34V
On-state resistance	R _{DSON}	typ. 50 mΩ
Nominal load current	I _{L(nom)}	2.6 A
Operating temperature range	$T_{\rm j}$	-40°C to 125°C
Stand-by current	I _{SSTB}	15 μΑ

Туре	Package	Marking
ITS4060S-SJ-N	PG-DSO-8	1060SN



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Block diagram and terms

1 Block diagram and terms

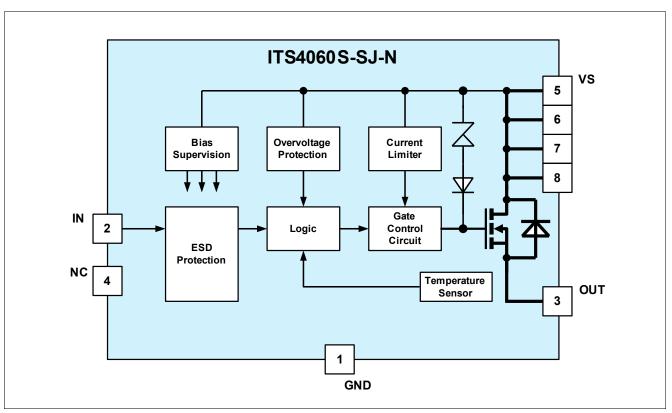


Figure 1 Block diagram

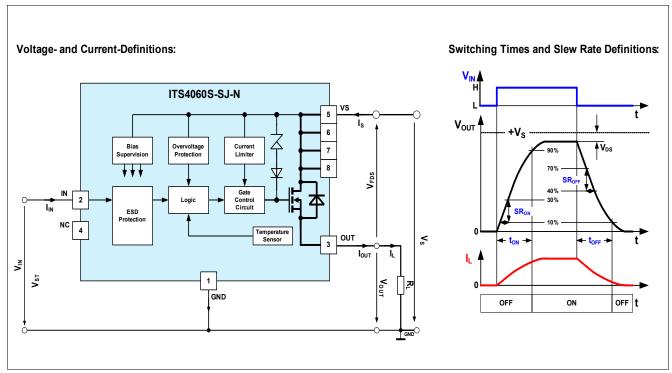


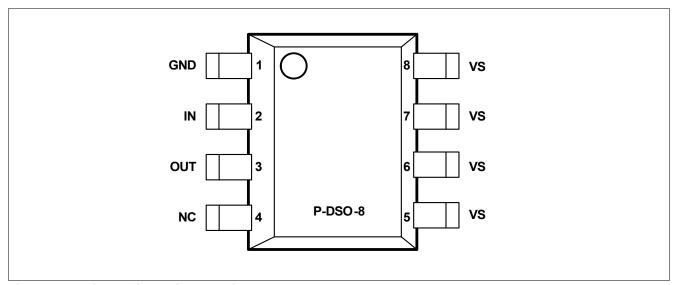
Figure 2 Terms - parameter definition



Pin configuration

Pin configuration 2

Pin assignment 2.1



Pin configuration top view, PG-DSO-8 Figure 3

Pin definitions and functions 2.2

Pin	Symbol	Function
1	GND	Logic ground
2	IN	Input, controls the power switch; the powerswitch is ON when high
3	OUT	Output to the load
4	NC	Not connected
5, 6, 7, 8	VS	Supply voltage (design the wiring for the maximum short circuit current and also for low thermal resistance)



General product characteristics

General product characteristics 3

3.1 Absolute maximum ratings

Absolute maximum ratings $^{1)}$ at $T_{\rm j}$ = 25°C unless otherwise specified. Currents flowing into Table 2 the device unless otherwise specified in chapter "Block Diagram and Terms"

Parameter	Symbol		Value	es	Unit	Note or	Number	
		Min.	Тур.	Max.		Test Condition		
Supply voltage VS		1	-		1			
Voltage	V_{S}	-	-	40	V	_	4.1.1	
Voltage for short circuit protection	$V_{\rm SSC}$	-	-	36	V	-40°C < T _j < 150°C	4.1.2	
Output stage OUT			•					
Output current; (short circuit current see electrical characteristics)	I _{OUT}	_	_	self limited	A	-	4.1.3	
Input IN			•					
Voltage	V_{IN}	-10	_	16	V	_	4.1.4	
Current	I _{IN}	-5	-	5	mA	_	4.1.5	
Temperatures			•					
Junction temperature	T _j	-40	-	125	°C	_	4.1.6	
Storage temperature	$T_{\rm stg}$	-55	-	125	°C	_	4.1.7	
Power dissipation			•					
Ta = 25 °C ²⁾	P _{tot}	_	_	1.5	W	_	4.1.8	
Inductive load switch-off energy dis			•					
$Tj = 125 \text{ °C}; V_S = 13.5V; IL = 1.5A^{3)}$	E _{AS}	_	_	900	mJ	single pulse	4.1.9	
ESD Susceptibility					1		-	
ESD susceptibility (input pin IN) V_{ESD}		-1	-	1	kV	HBM ⁴⁾	4.1.10	
ESD susceptibility (output pin OUT)	V_{ESD}	-6	_	6	kV	HBM ⁴⁾	4.1.12	
ESD susceptibility (all other pins)	V_{ESD}	-4	_	4	kV	HBM ⁴⁾	4.1.11	

¹⁾ Not subject to production test, specified by design

Note:

Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" the normal operating range. Protection functions are neither designed for continuous nor repetitive operation.

²⁾ Device on 50mm*50mm*1.5mm epoxy PCB FR4 with 6 cm2 (one layer, 70mm thick) copper area for Vbb connection. PCB is vertical without blown air

³⁾ Not subject to production test, specified by design

⁴⁾ ESD susceptibility HBM according to ANSI/ESDA/JEDEC JS001 (1.5 kΩ, 100 pF)



General product characteristics

3.2 **Functional range**

Table 3 **Functional range**

Parameter	Symbol		Values		Unit	Note or	Number
		Min.	Тур.	Max.		Test Condition	
Nominal operating voltage	V _S	5	_	34	V	V _S increasing	4.2.1

Note:

Within the functional range the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the related electrical characteristics table.

Thermal resistance 3.3

Note:

This thermal data was generated in accordance with JEDEC JESD51 standards. For more information, go to www.jedec.org.

Thermal resistance1) Table 4

Parameter	Symbol		Values			Note or	Number
		Min.	Тур.	Max.		Test Condition	
Thermal resistance - unction to pin5	R _{thj-pin5}	-	26.7	_	K/W	-	4.3.1
Thermal resistance - junction to ambient - 1s0p, minimal footprint	R _{thJA_1s0p}	-	140.1	_	K/W	2)	4.3.2
Thermal resistance - junction to ambient - 1s0p, 300mm ²	R _{thJA_1s0p_300mm}	-	85.8	-	K/W	3)	4.3.3
Thermal resistance - junction to ambient - 1s0p, 600mm ²	R _{thJA_1s0p_600mm}	-	74.7	-	K/W	4)	4.3.4
Thermal resistance - junction to ambient - 2s2p	R _{thJA_2s2p}	-	78.2	-	K/W	5)	4.3.5
Thermal resistance - junction to ambient with thermal vias - 2s2p	R _{thJA_2s2p}	-	76.6	_	K/W	6)	4.3.6

- 1) Not subject to production test, specified by design
- Specified R_{thJA} value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, footprint; the product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70μm Cu.
- 3) Specified R_{th,IA} value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, Cu, 300mm²; the product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70μm Cu.
- 4) Specified $R_{th,IA}$ value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, 600mm²; the product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70μm Cu.
- Specified R_{thJA} value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2s2p board; the product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 2 inner copper layers (2 x 70µm Cu, 2 x 35µm Cu).

6) Specified $R_{\rm thJA}$ value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2s2p board with two thermal vias; the product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 2 inner copper layers (2 x 70µm Cu, 2 x 35µm Cu. The diameter of the two vias are equal 0.3mm and have a plating of 25um with a copper heatsink area of 3mm x 2mm). JEDEC51-7: The two plated-through hole vias should have a solder land of no less than 1.25 mm diameter with a drill hole of no less than 0.85 mm diameter.



Electrical characteristics

Electrical characteristics 4

 V_s =13.5V; Tj = -40°C to 125°C; all voltages with respect to ground. Currents flowing into the Table 5 device unless otherwise specified in chapter "Block diagram and terms". Typical values at $V_{.} = 13.5 \text{V}, T_{.} = 25 ^{\circ} \text{C}$

Parameter	Symbol		Value	S	Unit	Note or	Number	
		Min.	Тур.	Max.		Test Condition		
Powerstage								
NMOS ON resistance	R _{DSON}	_	50	60	mΩ	$I_{OUT} = 2A; T_j = 25$ °C; 9V < V_S < 34V; $V_{IN} = 5$ V	5.0.1	
NMOS ON resistance	R_{DSON}	-	95	120	mΩ	$I_{OUT} = 2A; T_j = 125$ °C; 9V < V_S < 34V; $V_{IN} = 5$ V	5.0.2	
Nominal load current; device on PCB ¹⁾	I _{LNOM}	2.6	3.1	-	А	$T_{\text{pin5}} = 85^{\circ}\text{C}$	5.0.3	
Timings of power stages ²⁾								
Turn ON time (to 90% of V_{out}); L to H transition of V_{IN}	t _{ON}	-	90	180	μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 47 Ω	5.0.4	
Turn OFF time (to 10% of V_{out}); H to L transition of V_{IN}	t _{OFF}	-	110	230	μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 47 Ω	5.0.5	
ON-slew rate; $\Delta V_{\rm OUT}/\Delta t$ (10 to 30% of $V_{\rm out}$); L to H transition of $V_{\rm IN}$	SR _{ON}	_	0.7	1.5	V/μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 47 Ω	5.0.6	
OFF-slew rate; ΔV _{OUT} /Δt (70 to 40% of V _{out}); H to L transition of V _{IN}	SR _{OFF}	_	0.7	1.5	V/μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 47 Ω	5.0.7	
Under voltage lockout (charge p	oump start	-stop-r	estart)					
Supply undervoltage; charge pump stop voltage	V _{SUV}	_	-	5.5	V	$V_{\rm S}$ decreasing	5.0.8	
Supply startup voltage; Charge pump restart voltage	V _{SSU}	-	4.0	5.5	V	$V_{\rm S}$ increasing	5.0.9	
Current consumption		Ш		II.		,	- 11	
Operating current	I_{GND}	_	0.8	1.5	mA	V _{IN} = 5V	5.0.10	
Standby current	I _{SSTB}	-	-	10	μΑ	$V_{IN} = 0V; V_{OUT} = 0V$ -40°C < T_i < 85°C	5.0.11	
Standby current	I _{SSTB}	_	-	15	μΑ	$V_{IN} = 0V; V_{OUT} = 0V$ $T_{i} = 125^{\circ}C$	5.0.12	
Output leakage current	I _{OUTLK}	_	_	5	μΑ	$V_{\rm IN}$ = 0V; $V_{\rm OUT}$ = 0V	5.0.13	
Protection functions 3)		1	I	ı				
Initial peak short circuit current limit	I _{LSCP}	-	_	28	А	$T_{\rm j}$ = -40°C; $V_{\rm S}$ = 20V $V_{\rm IN}$ = 5.0V; $t_{\rm m}$ =150 μ s	5.0.14	



Electrical characteristics

 V_s =13.5V; Tj = -40°C to 125°C; all voltages with respect to ground. Currents flowing into the Table 5 device unless otherwise specified in chapter "Block diagram and terms". Typical values at $V_{\rm s}$ = 13.5V, $T_{\rm i}$ = 25°C

Parameter	Symbol		Value	s	Unit	Note or	Number	
		Min.	Тур.	Max.		Test Condition		
Initial peak short circuit current limit	I _{LSCP}	_	17	-	А	$T_{\rm j}$ = 25°C; $V_{\rm S}$ = 20V $V_{\rm IN}$ = 5.0V; $t_{\rm m}$ =150 μ s	5.0.15	
Initial peak short circuit current limit	I _{LSCP}	9	-	-	А	$T_{\rm j}$ =125°C; $V_{\rm S}$ = 20V $V_{\rm IN}$ = 5.0V; $t_{\rm m}$ =150 μ s	5.0.16	
Repetitive short circuit current limit $T_j = T_{jTrip}$; see timing diagrams	I _{LSCR}	_	12	-	А	V _{IN} = 5.0V	5.0.17	
Output clamp at $V_{\text{OUT}} = V_{\text{S}} - V_{\text{DSCL}}$ (inductive load switch off)	V_{DSCL}	41	47	-	V	I _S = 4mA	5.0.18	
Overvoltage protection $V_{\text{OUT}} = V_{\text{S}} - V_{\text{ONCL}}$	V _{SAZ}	41	-	-	V	I _S = 4mA	5.0.19	
Thermal overload trip temperature	$T_{\rm jTrip}$	150	-	-	°C	-	5.0.20	
Thermal hysteresis	T_{HYS}	_	10	_	K	_	5.0.21	
Reverse battery ⁴⁾		1	T.	II.	· ·	1		
Continuous reverse battery voltage	V _{SREV}	- 32	-	-	V	-	5.0.22	
Forward voltage of the drain- source reverse diode	V _{FDS}	-	600	-	mV	$I_{FDS} = 200 \text{mA};$ $V_{IN} = 0 \text{V}; T_{i} = 125 ^{\circ} \text{C}$	5.0.23	
Input interface; pin IN	1							
Input turn-ON voltage (logic input high-level)	V _{INON}	2.2	-	-	V	-	5.0.24	
Input turn-OFF voltage (logic input low-level)	V _{INOFF}	-	-	0.8	V	-	5.0.25	
Input threshold hysteresis	V_{INHYS}	-	0.3	_	٧	_	5.0.26	
Off state input current	I _{INOFF}	1	_	30	μΑ	$V_{IN} = 0.7V$	5.0.27	
On state input current	I _{INON}	1	_	30	μΑ	V _{IN} = 5.0V	5.0.28	
Input resistance	R _{IN}	1.5	3.5	5.0	kΩ	_	5.0.29	

¹⁾ Device on 50mm x 50mm x 1,5mm epoxy FR4 PCB with 6cm² (one layer copper 70um thick) copper area for supply voltage connection. PCB in vertical position without blown air.

²⁾ Timing values only with high slewrate input signal; otherwise slower.

³⁾ Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.

⁴⁾ Requires a 150 Ω resistor in GND connection. The reverse load current trough the intrinsic drain-source diode of the power-MOS has to be limited by the connected load. Power dissipation is higher compared to normal operation due to the voltage drop across the drain-source diode. The temperature protection is not functional during reverse current operation! Input current has to be limited (see max ratings).

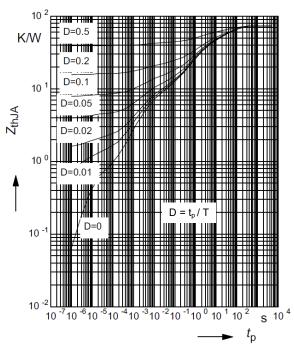


Typical performance graphs

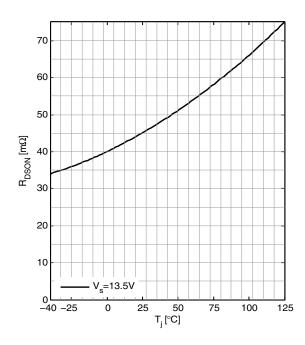
Typical performance graphs 5

Typical characteristics

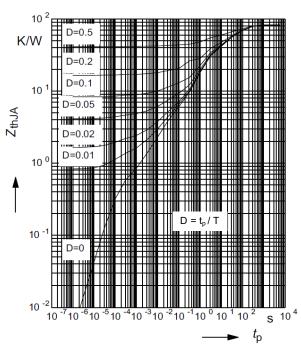
Transient thermal impedance Z_{thJA} versus pulse time t_p @ 6cm² heatsink area



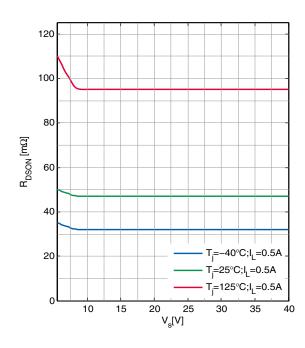
On-resistance R_{DSON} versus junction temperature Ti



Transient thermal impedance Z_{thJA} versus pulse time t_p @ min. footprint



On-resistance R_{DSON} versus supply voltage Vs



Smart high-side NMOS-power switch

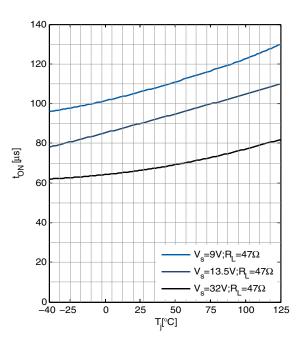
ITS4060S-SJ-N



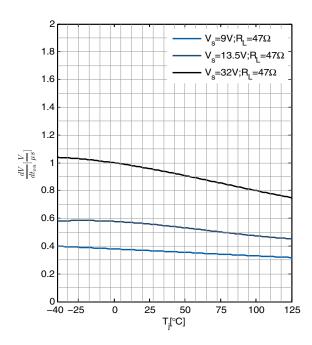
Typical performance graphs

Typical characteristics

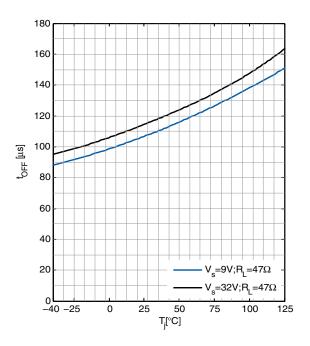
Switch ON time t_{ON} versus junction temperature T_i



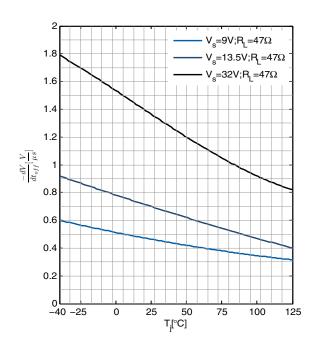
ON slewrate SR_{ON} versus junction temperature T_i



Switch OFF time t_{OFF} versus junction temperature T_i



OFF slewrate SR_{OFF} versus junction temperature T_i



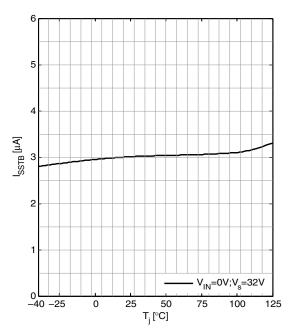
Smart high-side NMOS-power switch

ITS4060S-SJ-N

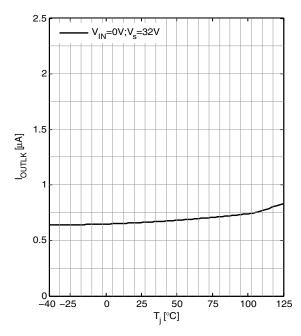
Typical performance graphs

Typical characteristics

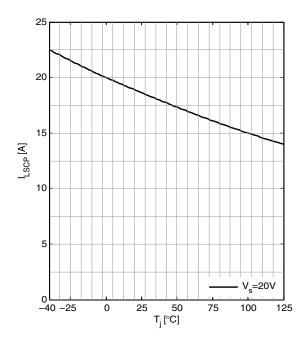
Standby current I_{SSTB} versus junction temperature $T_{\rm j}$



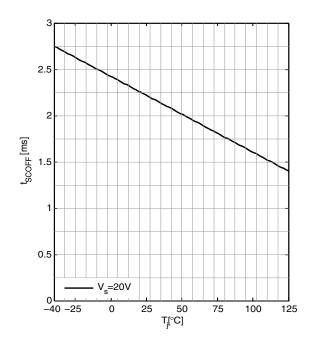
Output leakage current I_{OUTLK} versus junction temperature T_i



Initial peak short circuit current limit $I_{\rm LSCP}$ versus junction temperature T_i



Initial short circuit shutdown time t_{SCOFF} versus junction temperature T_i

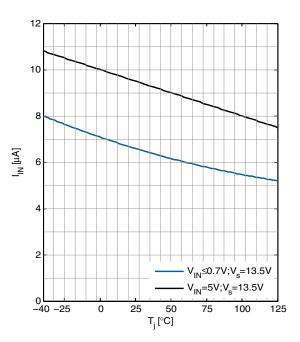




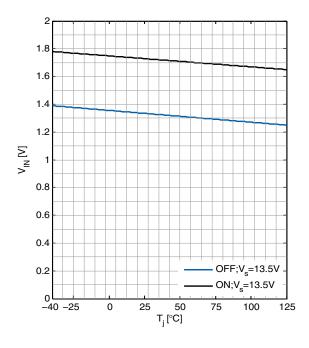
Typical performance graphs

Typical characteristics

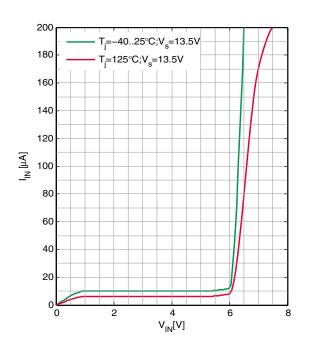
Input current consumption I_{IN} versus junction temperature $T_{\rm j}$



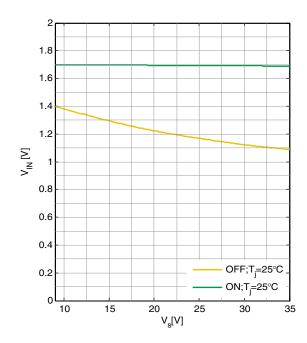
Input threshold voltage $V_{\mathrm{INH,L}}$ versus junction temperature $T_{\rm j}$



Input current consumption I_{IN} versus input voltage V_{IN}



Input threshold voltage $V_{\rm INH,L}$ versus supply voltage V_S

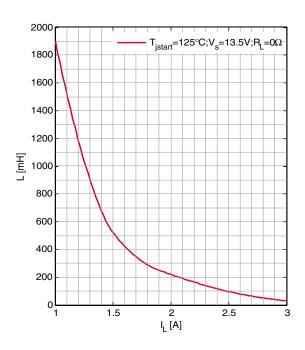




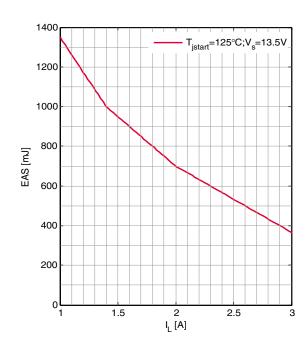
Typical performance graphs

Typical characteristics

Max. allowable load inductance L versus load current I_L



Max. allowable inductive single pulse switch-off energy E_{AS} versus load current I_{L}



ITS4060S-SJ-N



Application information

Application information 6

Note:

The following information is given as a hint for the implementation of the device only and shall not be regarded as a description or warranty of a certain functionality, condition or quality of the device.

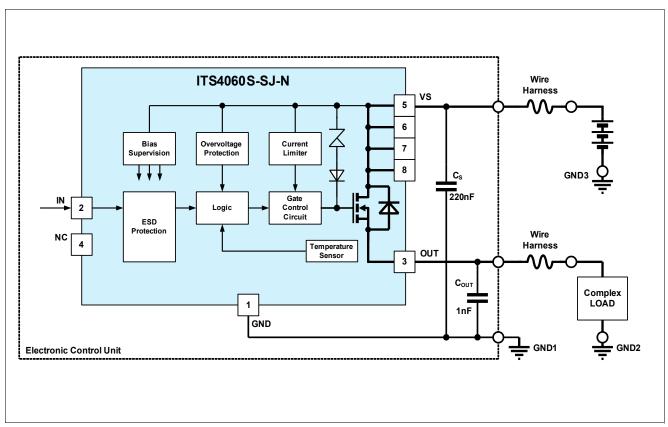


Figure 4 **Application diagram**

The ITS4060S-SJ-N can be connected directly to a supply network. It is recommended to place a ceramic capacitor (e.g. C_s = 220nF) between supply and GND of the ECU to avoid line disturbances. Wire harness inductors/resistors are sketched in the application circuit above.

The complex load (resistive, capacitive or inductive) must be connected to the output pin OUT.

A built-in current limit protects the device against destruction.

The ITS4060S-SJ-N can be switched on and off with standard logic ground related logic signal at pin IN.

In standby mode (IN=L) the ITS4060S-SJ-N is deactivated with very low current consumption.

The output voltage slope is controlled during on and off transition to minimize emissions. Only a small ceramic capacitor COUT=1nF is recommended to attenuate RF noise.

In the following chapters the main features, some typical waverforms and the protection behavior of the ITS4060S-SJ-N is shown. For further details please refer to application notes on the Infineon homepage.

Note: This is a very simplified example of an application circuit. The function must be verified in the real application.

Application information

6.1 **Special feature description**

Supply over voltage:

ITS4060S-SJ-N V_{out} GND ZL R_{GND}

If over-voltage is applied to the $\ensuremath{\text{V}}_{\ensuremath{\text{S}}}\text{-Pin}$:

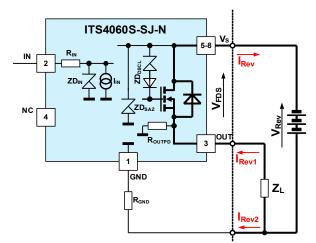
Voltage is limited to V_{ZDSAZ}; current can be calculated:

 $I_{ZDSAZ} = (V_S - V_{ZDSAZ}) / R_{GND}$

A typical value for RGND is 150Ω .

In case of ESD pulse on the input pin there is in both polarities a peak current I_{INpeak} ~ V_{ESD} / R_{IN}

Supply reverse voltage:



If reverse voltage is applied to the device:

1.) Current via load resistance RL:

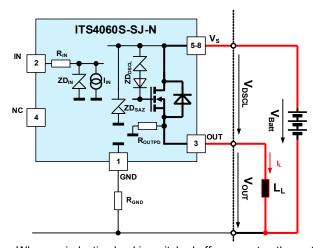
 $I_{Rev1} = (V_{Rev} - V_{FDS}) / R_{L}$

2.) Current via Input pin IN and dignostic pin ST:

 $I_{Rev2} = I_{ST} + I_{IN} \sim (V_{Rev} - V_{CC})/R_{IN} + (V_{Rev} - V_{CC})/R_{ST1,2}$ Current I_{ST} must be limited with the extrernal series resistor R_{STS} . Both currents will sum up to:

 $I_{Rev} = I_{Rev1} + I_{Rev2}$

Drain-Source power stage clamper V_{DSCL}:

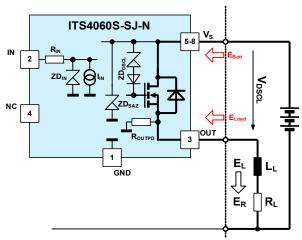


When an inductive load is switched off a current path must be established until the current is sloped down to zero (all energy removed from the inductive load). For that purpose the series combination $Z_{\mbox{\scriptsize DSCL}}$ is connected between Gate and Drain of the power DMOS acting as an active clamp.

When the device is switched off, the voltage at OUT turns negative until V_{DSCL} is reached.

The voltage on the inductive load is the difference between V_{DSCL} and V_{S} .

Energy calculation:



Energy stored in the load inductance is given by: $E_L = I_L^{2*}L/2$

While demagnetizing the load inductance the energy dissipated by the Power-DMOS is:

$$E_{AS} = E_S + E_L - E_R$$

With an approximate solution for $R_1 = 0\Omega$:

 $E_{AS} = \frac{1}{2} * L * I_{L}^{2} * \{ (1 - V_{S} / (V_{S} - V_{DSCL}) \}$

Special feature description Figure 5

Application information

Typical application waveforms 6.2

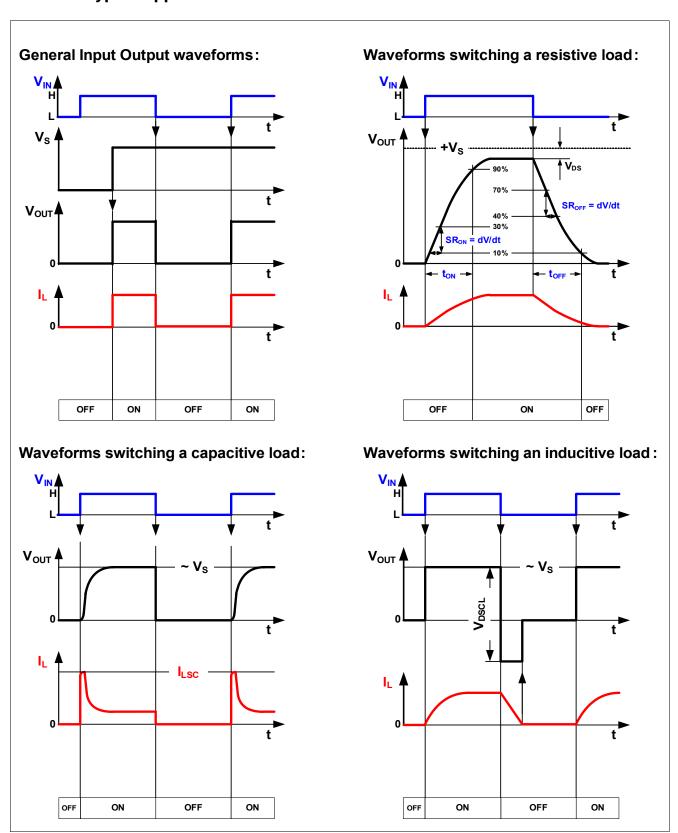


Figure 6 Typical application waveforms of the ITS4060S-SJ-N



Application information

Protection behavior 6.3

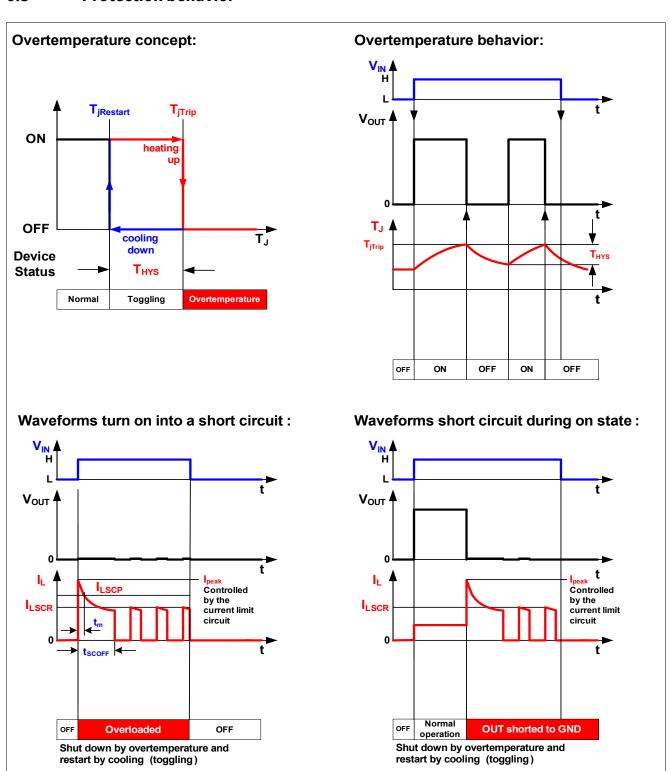


Figure 7 Protective behavior of the ITS4060S-SJ-N



Package information

7 Package information

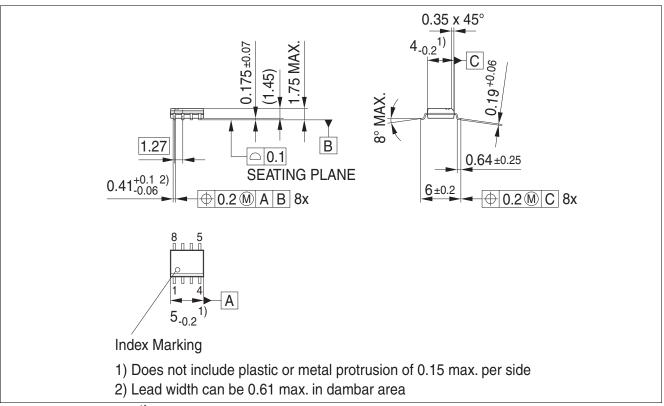


Figure 8 PG-DSO-8¹⁾

Green Product (RoHS compliant)

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020).

Further information on packages

https://www.infineon.com/packages

Smart high-side NMOS-power switch



Revision history



Revision history 8

Revision	Date	Changes
1.10	2019-07-25	Datasheet updated: - ESD ratings for HBM updated according ANSI/ESDA/JEDEC JS-001 - Editorial changes
1.0	12-09-01	Datasheet release

Trademarks

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Do you have a question about any aspect of this document?

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